

Search Notes

Application/Control No.

10/684,410

Examiner

C. Melissa Koslow

Applicant(s)/Patent under
Reexamination

YAMAZAKI ET AL.

Art Unit

1755

SEARCHED

Class	Subclass	Date	Examiner
348	333.01	5/23/2005	/

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
update search	5/18/2005	C
google search: terms "ionic impurities: and (oled or led or diode)	5/18/2005	
W. Garber for search in 348 since now has structure	5/23/2005	